


<b>Search Notes</b>  	<b>Application/Control No.</b>  10589747	<b>Applicant(s)/Patent Under Reexamination</b>  HIGAKI ET AL.
	<b>Examiner</b>  Tsz K Chiu	<b>Art Unit</b>  2822

SEARCHED			
Class	Subclass	Date	Examiner
257	E21.53,E21.511,E33.057	3/1/09	TC
438	310, 209, 667, 26,22	3/1/09	TC
257	99, 434, E23.005,E23.067,E31.11	10/12/09	TC

SEARCH NOTES		
Search Notes	Date	Examiner
East text searched	3/1/09	TC
Updated search	10/12/09	TC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	interference searched	10/12/09	TC

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